Search Notes			

Application No.	Applicant(s)	
10/735,956	HATSCH ET AL.	
Examiner	Art Unit	
Tan V Mai	2193	

SEARCHED			
Class	Subclass	Date	Examiner
708	708-709, 702-703	3/25/2005	MAI

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
	<u>.</u>		
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SEARCH NO (INCLUDING SEARCH		)
	DATE	EXMR
Inventor search Double Patenting Check Data Bases Search (see attached copy)	3/25/2005	MAI